

2N5346 (SILICON)

thru

2N5349

MEDIUM-POWER NPN SILICON TRANSISTORS

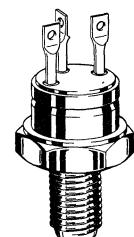
. . . designed for switching and wide-band amplifier applications.

- Low Collector-Emitter Saturation Voltage — $V_{CE(sat)} = 1.2$ Vdc (Max) @ $I_C = 7.0$ Adc
- DC Current Gain Specified to 5 Amperes
- Excellent Safe Operating Area
- Packaged in the Compact, High Dissipation TO-59 Case
- Isolated Collector Configuration

7 AMPERE POWER TRANSISTORS

NPN SILICON

80-100 VOLTS
60 WATTS



*MAXIMUM RATINGS

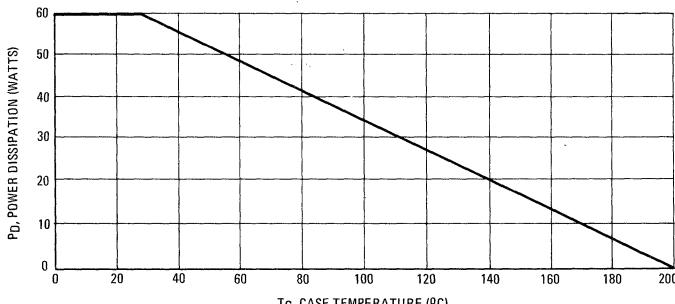
Rating	Symbol	2N5346 2N5347	2N5348 2N5349	Unit
Collector-Emitter Voltage	V_{CEO}	80	100	Vdc
Collector-Base Voltage	V_{CB}	80	100	Vdc
Emitter-Base Voltage	V_{EB}		6.0	Vdc
Collector Current — Continuous	I_C		7.0	Adc
Base Current	I_B		1.0	Adc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D		60 343	Watts mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J , T_{stg}		-65 to +200	$^\circ\text{C}$

THERMAL CHARACTERISTICS

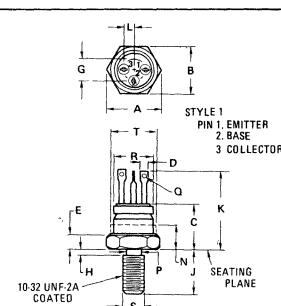
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	θ_{JC}	2.91	$^\circ\text{C}/\text{W}$

*Indicates JEDEC Registered Data

FIGURE 1 — POWER-TEMPERATURE DERATING CURVE



Safe Area Curves are indicated by Figure 5. All limits are applicable and must be observed.



DIM	MILLIMETERS	INCHES
B	10.77	0.424
C	8.13	0.320
E	2.28	0.090
G	4.76	0.186
H		0.198
J	10.16	0.400
K	14.48	0.570
L	2.29	0.090
N	—	0.250
P	4.14	0.163
R	6.08	0.240
S	4.212	0.1658
T	9.68	0.380
		0.437

All JEDEC dimensions and notes apply.
Collector isolated from case.

CASE 160-03
TO-59

ISOLATED COLLECTOR

2N5346 thru 2N5349 (continued)

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Fig. No.	Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Sustaining Voltage ($I_C = 50 \text{ mA}_\text{dc}, I_B = 0$)	2N5346, 2N5347 2N5348, 2N5349	$V_{CEO(\text{sus})}$	80 100	-	Vdc
Collector Cutoff Current ($V_{CE} = 75 \text{ Vdc}, I_B = 0$)	2N5346, 2N5347	I_{CEO}	-	100	μA_dc
($V_{CE} = 90 \text{ Vdc}, I_B = 0$)	2N5348, 2N5349		-	100	
Collector Cutoff Current ($V_{CE} = 75 \text{ Vdc}, V_{EB(\text{off})} = 1.5 \text{ Vdc}$)	2N5346, 2N5347	I_{CEX}	-	10	μA_dc
($V_{CE} = 90 \text{ Vdc}, V_{EB(\text{off})} = 1.5 \text{ Vdc}$)	2N5348, 2N5349		-	10	
($V_{CE} = 75 \text{ Vdc}, V_{EB(\text{off})} = 1.5 \text{ Vdc}, T_C = 150^\circ\text{C}$)	2N5346, 2N5347		-	1.0	mA_dc
($V_{CE} = 90 \text{ Vdc}, V_{EB(\text{off})} = 1.5 \text{ Vdc}, T_C = 150^\circ\text{C}$)	2N5348, 2N5349		-	1.0	
Collector Cutoff Current ($V_{CB} = \text{Rated } V_{CB}, I_E = 0$)	-	I_{CBO}	-	10	μA_dc
Emitter Cutoff Current ($V_{EB} = 6.0 \text{ Vdc}, I_C = 0$)	-	I_{EBO}	-	100	μA_dc
ON CHARACTERISTICS (1)					
DC Current Gain ($I_C = 500 \text{ mA}_\text{dc}, V_{CE} = 2.0 \text{ Vdc}$)	2N5346, 2N5348 2N5347, 2N5349	h_{FE}	30 60	-	-
($I_C = 2.0 \text{ Adc}, V_{CE} = 2.0 \text{ Vdc}$)	2N5346, 2N5348 2N5347, 2N5349		30 60	120 240	
($I_C = 5.0 \text{ Adc}, V_{CE} = 2.0 \text{ Vdc}$)	2N5346, 2N5348 2N5347, 2N5349		20 40	-	-
Collector-Emitter Saturation Voltage ($I_C = 2.0 \text{ Adc}, I_B = 0.2 \text{ Adc}$)	9,11,13	$V_{CE(\text{sat})}$	-	0.7	Vdc
($I_C = 7.0 \text{ Adc}, I_B = 0.7 \text{ Adc}$)			-	1.2	
Base-Emitter Saturation Voltage ($I_C = 2.0 \text{ Adc}, I_B = 0.2 \text{ Adc}$)	11, 13	$V_{BE(\text{sat})}$	-	1.2	Vdc
($I_C = 7.0 \text{ Adc}, I_B = 0.7 \text{ Adc}$)			-	2.0	
DYNAMIC CHARACTERISTICS					
Current-Gain-Bandwidth Product ($I_C = 500 \text{ mA}_\text{dc}, V_{CE} = 10 \text{ Vdc}, f = 10 \text{ MHz}$)	-	f_T	30	-	MHz
Output Capacitance ($V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 100 \text{ kHz}$)	7	C_{ob}	-	250	pF
Input Capacitance ($V_{BE} = 2.0 \text{ Vdc}, I_C = 0, f = 100 \text{ kHz}$)	7	C_{ib}	-	1,000	pF
SWITCHING CHARACTERISTICS					
Delay Time ($V_{CC} = 40 \text{ Vdc}, V_{EB(\text{off})} = 3.0 \text{ Vdc}, I_C = 2.0 \text{ Adc}, I_{B1} = 200 \text{ mA}_\text{dc}$)	2,3	t_d	-	100	ns
Rise Time		t_r	-	100	ns
Storage Time	2,6	t_s	-	2.0	μs
Fall Time		t_f	-	200	ns

*Indicates JEDEC Registered Data.

(1)Pulse Test: Pulse Width $\approx 300 \mu\text{s}$, Duty Cycle $\approx 2.0\%$.

FIGURE 2 – SWITCHING TIME TEST CIRCUIT

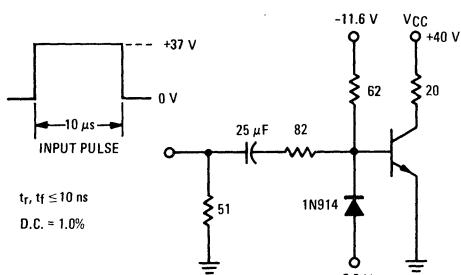
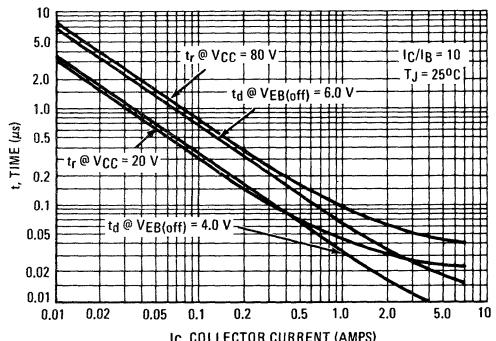


FIGURE 3 – TURN-ON TIME



2N5346 thru 2N5349 (continued)

FIGURE 4 – THERMAL RESPONSE

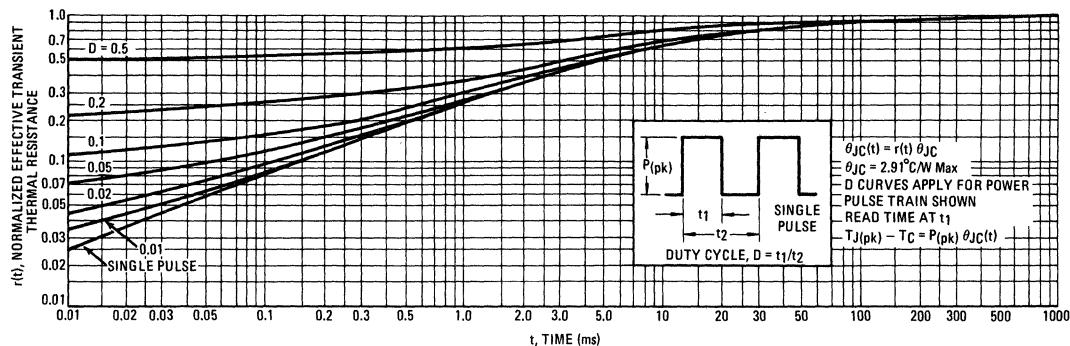
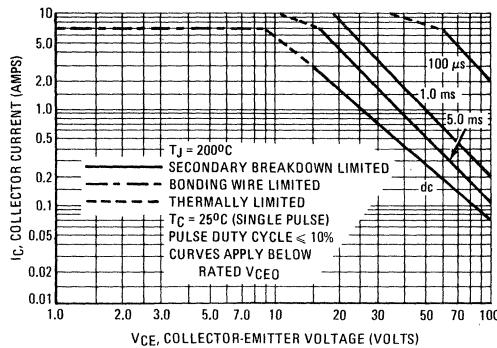


FIGURE 5 – ACTIVE-REGION SAFE OPERATING AREA



There are two limitations on the power handling ability of a transistor: junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 5 is based on $T_J(pk) = 200^\circ\text{C}$; T_C is variable depending on conditions. Pulse curves are valid for duty cycles of 10% provided $T_J(pk) \leq 200^\circ\text{C}$. $T_J(pk)$ may be calculated from the data in Figure 4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by secondary breakdown.

FIGURE 6 – TURN-OFF TIME

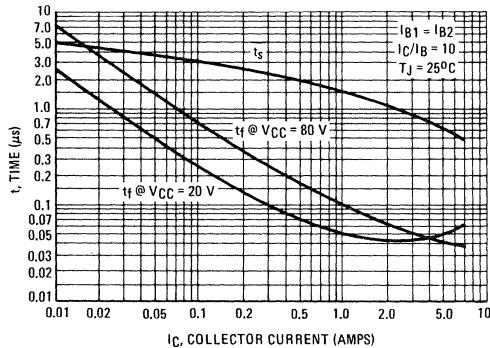
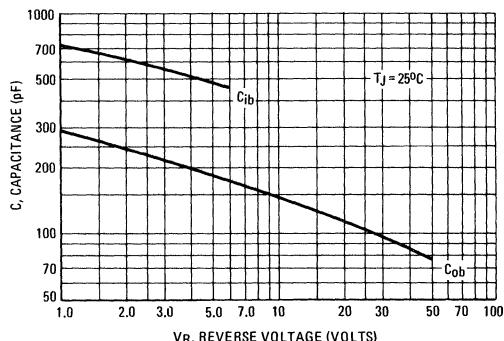


FIGURE 7 – CAPACITANCE versus VOLTAGE



2N5346 thru 2N5349 (continued)

FIGURE 8 – DC CURRENT GAIN

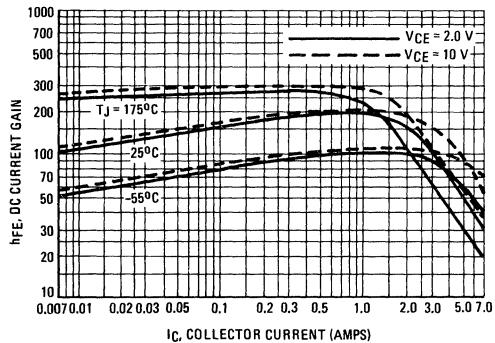


FIGURE 10 – EFFECTS OF BASE-EMITTER RESISTANCE

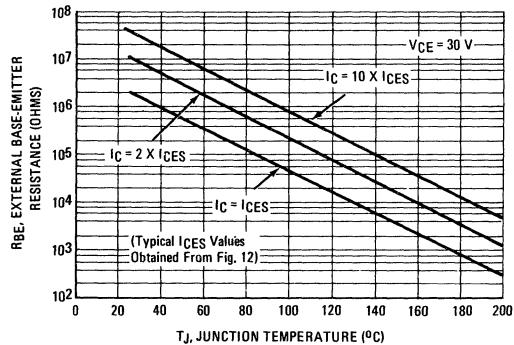


FIGURE 12 – COLLECTOR CUT-OFF REGION

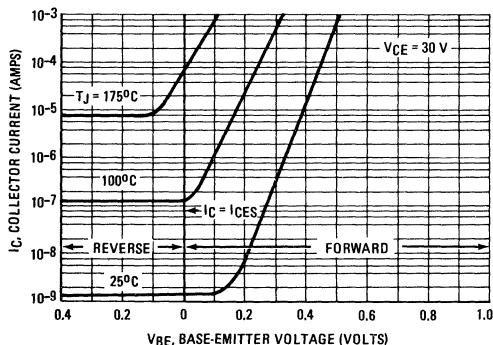


FIGURE 9 – COLLECTOR SATURATION REGION

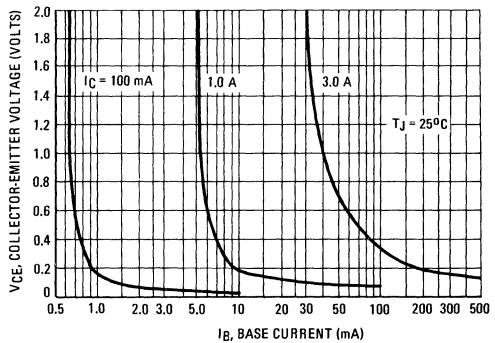


FIGURE 11 – “ON” VOLTAGES

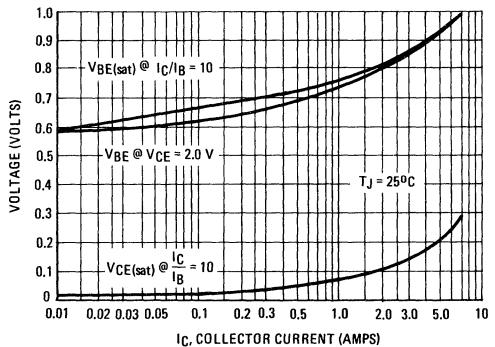


FIGURE 13 – TEMPERATURE COEFFICIENTS

